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APPLICATION NO. FILING DATE		FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
09/836,369 04/18/2001		Yuichi Hashimoto	35.G2780	6891	
5514 75	590 01/22/2004		EXAMINER		
FITZPATRIC 30 ROCKEFEL	K CELLA HARPER & ;	CLEVELAND, MICHAEL B			
NEW YORK,		ART UNIT	PAPER NUMBER		
		1762			
			DATE MAILED: 01/22/2004		

Please find below and/or attached an Office communication concerning this application or proceeding.

<u> </u>	·		_			m1:			
			Application	on No.	Applicant(s)				
Office Action Summary			09/836,36	59	HASHIMOTO ET A	L.			
		Examine	•	Art Unit					
			Michael C		1762	<del></del>			
Period fo	The MAILING DATE of this commun	nication appea	ars on the	e cover sheet with the c	orrespondence ado	ress			
THE - Exte after - If the - If NO - Failu - Any	ORTENED STATUTORY PERIOD F MAILING DATE OF THIS COMMUN nsions of time may be available under the provisions SIX (6) MONTHS from the mailing date of this comi e period for reply specified above is less than thirty (3) period for reply is specified above, the maximum s pre to reply within the set or extended period for reply reply received by the Office later than three months and patent term adjustment. See 37 CFR 1.704(b).	ICATION. s of 37 CFR 1.136( munication. 30) days, a reply w tatutory period will y will, by statute, ca	(a). In no even within the state apply and with	ent, however, may a reply be tim  Utory minimum of thirty (30) days  Il expire SIX (6) MONTHS from to become ARANDONER	ely filed  will be considered timely, he mailing date of this con	nmunication.			
Status									
1)[	Responsive to communication(s) filed on <u>27 October 2003</u> .								
2a)⊠	This action is <b>FINAL</b> . 2b) ☐ This action is non-final.								
3)	Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.								
Dispositi	on of Claims								
4)🖂	Claim(s) 1,3,5 and 9-13 is/are pending in the application.								
	4a) Of the above claim(s) is/are withdrawn from consideration.								
	) Claim(s) is/are allowed.								
6)⊠	6)⊠ Claim(s) <u>1, 3, 5, 9-13</u> is/are rejected.								
7)	Claim(s) is/are objected to.								
8)	Claim(s) are subject to restrict	ction and/or e	lection re	quirement.					
Applicati	on Papers					·			
9) 🗌 -	The specification is objected to by the	e Examiner.							
10) 🔲 -	The drawing(s) filed on is/are:	a)⊡ accept	ted or b)[	objected to by the E	xaminer.				
	Applicant may not request that any object								
	Replacement drawing sheet(s) including					. 1.121(d).			
11)	Γhe oath or declaration is objected to	by the Exam	niner. Not	te the attached Office A	Action or form PTC	-152.			
Priority u	nder 35 U.S.C. §§ 119 and 120								
12) <u> </u>	Acknowledgment is made of a claim ☐ All b) ☐ Some * c) ☐ None of:				·(d) or (f).				
	<ol> <li>Certified copies of the priority</li> <li>Certified copies of the priority</li> </ol>	documents hi	ave beer ave beer	l received. Lreceived in Application	a No				
	<ol> <li>Copies of the certified copies of the certified copies.</li> </ol>	of the priority	documer	nts have been received	in this National St	age			
	application from the Internation	nal Bureau (F	PCT Rule	17.2(a)).					
_13)[_] A∈	ee the attached detailed Office action cknowledgment is made of a claim force a specific reference was included	or domestic pi	riority und	der 35 U.S.C. § 119(e)	(to a provisional a	pplication) ata Sheet			
37	CFR 1.78.								
a) 1⊿\□ ∧	The translation of the foreign lan	guage provis	ional app	lication has been recei	ved.				
ref	cknowledgment is made of a claim for ference was included in the first sent	ence of the s	pecificati	der 35 U.S.C. §§ 120 a on or in an Application	nd/or 121 since a : Data Sheet. 37 CF	specific FR 1.78.			
Attachment(	· (s)								
	of References Cited (PTO-892)		4	4)  Interview Summary (P	TO-413) Paper No(s).				
	of Draftsperson's Patent Drawing Review (Pation Disclosure Statement(s) (PTO-1449) Pation Disclosure Statement(s)		, ;	5) Notice of Informal Pate 3) Other:					
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### **DETAILED ACTION**

## Claim Rejections - 35 USC § 103

- 1. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
  - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 2. Claims 1, 3, 5, 9, and 12-13 are rejected under 35 U.S.C. 103(a) as being unpatentable over Yamazaki et al. (U.S. Patent 6,420,834, hereafter '834) in view of Matsuura et al. (U.S. Patent 6,001,413, hereafter '413).

Claim 1: '834, Embodiment 2 (Figure 3), teaches a method of making an organic (electro)luminescent (EL) device comprising the steps of:

forming a first electrode (104, 311) on a substrate (col. 3, line 60-col. 4, line 16; col. 6, lines 18-20),

evaporating an organic layer on the first electrode (col. 4, lines 14-30; col. 6, lines 7-46); and

forming a second electrode on the organic layer (col. 4, lines 31-48),

wherein the organic layer is formed by applying a voltage to the first electrode (col. 6, lines 25-38) without generating a plasma (No plasma is used in Embodiment 2; compare and contrast to Embodiment 4 in col. 8). (The voltages referred to must be consistently positive and negative to achieve the repulsion characteristics described at col. 5, lines 9-32. Therefore, they must be DC voltages.)

The first electrode is driven by a positive voltage (col. 6, lines 32-38). A positive voltage drives an electrode as an anode (col. 5, lines 2-14).

'834 does not explicitly teach that the deposited EL layer is a hole-transporting layer, but does teach that EL layer (851), which may be deposited by the method of Fig. 3 (i.e., embodiment 2) (col. 17, lines 55-56) may be include a hole-transporting layer (col. 18, lines 1-5). Therefore, the fair teaching of '834 is that the hole-transporting layer may be deposited by the method of Fig. 3. However, the examiner takes Official Notice that it is well known in the art of

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organic EL devices for organic hole-transporting compounds to be organic compounds deposited by vapor deposition. See, for example, 413, col. 6, lines 6-10. Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to have deposited an organic hole-transporting layer by the method of Embodiment 2 with a reasonable expectation of success because '834 teaches that the EL layer may comprise a hole-transporting layer and that such layers may be deposited by the vapor deposition method of Embodiment 2 and because '413 confirms that it is known in the art to deposit such organic hole-transporting layers by vapor deposition.

Claim 3: The organic layer is formed by resistance heating evaporation ('834, col. 5, line 67-col. 6, line 2; '413, col. 6, lines 50-68).

Claim 5: The anode may be indium tin oxide (col. 3, lines 63-65, col. 11, lines 59-61; col. 17, lines 33-35).

Claim 9: Yamazaki '834 describes formation of an EL device by deposition of an organic layer on an electrode while driving it as an anode, as described in the discussion of claim 1, above. It does not teach an oxygen or inert gas plasma surface treatment of the electrode before depositing the organic layer.

Matsuura '413 teach that in forming EL devices, it is desirable to clean the ITO anode with an oxygen and inert gas (such as argon) plasma (col. 6, lines 4-37) in order to prevent contamination (col. 11, lines 39-61). The subsequent organic EL layer(s) are deposited on the cleaned substrate without breaking vacuum also to prevent contamination (col. 6, lines 43-61; Abstract; col. 2, lines 18-50). Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to have plasma cleaned the ITO anode of Yamazaki '834 and then deposited its organic layer without breaking vacuum because Matsuura '413 teaches that plasma cleaning and then deposition without breaking vacuum would have reduced the effect of contaminants on the resulting EL device.

Claims 12-13: '834 is silent as to the voltage to be applied to the electrode during deposition. However, col. 5, lines 9-32 describe that the operation of the invention occurs because the banks (105b) on the substrate where deposition is not desired are given the same charge as the EL material being deposited, and therefore the banks repel the EL material. Likewise, the chamber walls and the substrate holder may be given the same charge also to repel

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the material (col. 6, lines 11-32). It is therefore apparent that the EL material is therefore attracted to the oppositely-charged electrodes because opposite charges attract and like charges repel. The degree of attraction or repulsion is controlled by the magnitude of the voltages. Larger voltages would have provided greater degrees of attraction or repulsion, but would have required more energy. Therefore, the positive and negative voltage are result-effective variables because they affect the degrees of attraction and repulsion and the energy cost during deposition. Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to have optimized the voltages for the best balance of attraction to the electrodes, repulsion from the non-deposition surfaces and cost, particularly in view of the teachings of '834 that the determination of the voltages may be determined by the implementers (col. 5, lines 9-19).

3. Claims 10-11 are rejected under 35 U.S.C. 103(a) as being unpatentable over Yamazaki '834 in view of Matsuura '413, as applied to claim 9, above, and further in view of Leiphart (U.S. Patent 6,187,151, hereafter '151). (Ameen et al. (U.S. Patent 5,834,371, hereafter '371) is further cited as evidence in the discussion of claim 11.)

Yamazaki '834 and Matsuura '413 teach the construction of an EL device by cleaning an ITO electrode in an oxygen/argon plasma, as discussed above. They are silent as to the energies of the ions in the plasma, and therefore do not teach 10-80 eV for oxygen nor 20-100 eV for argon.

'151 teaches that during plasma cleaning, the energy level of the ions should be controlled in order to prevent damage to the substrate (col. 3, lines 56-64), and particularly suggests that ion energies of about 0-50 eV may be used when performing plasma cleaning with oxygen or argon (col. 3, lines 24-56). Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to have used oxygen and/or argon ion energies of 0-50 eV as the particular ion energies in the invention of '834 and '413 in order to have prevented the cleaning ions from having damaged the substrate. It would have been obvious to one of ordinary skill in the art at the time the invention was made to have selected the overlapping portion of the range disclosed by the reference because overlapping ranges have been held to be a *prima facie* case of obviousness, see *In re Malagari*, 182 U.S.P.Q. 549.

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Claim 11: A plasma works by stripping atoms of their electrons. Thus, an argon plasma inherently creates positive argon ions. See '371, col. 2, lines 4-29.

## Response to Arguments

4. Applicant's arguments filed 10/27/2003 have been fully considered but they are not persuasive.

Applicant argues that Yamazaki charges the EL material, and Applicant argues that the evaporated material should not be charged. The argument is unconvincing because the claims do not exclude applying a voltage to the evaporated material. Applicant's arguments regarding the negative effects of charging the evaporated material are unconvincing because they are not commensurate in scope with the claims, are not supported by evidence, and are contradicted by Yamazaki '834, which teaches that films of desired thicknesses (col. 17, line 55-col. 18, line 20) may be achieved.

#### Conclusion

5. Applicant's amendment necessitated the new ground(s) of rejection presented in this Office action. Accordingly, **THIS ACTION IS MADE FINAL**. See MPEP § 706.07(a). Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the date of this final action.

6. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Michael Cleveland whose telephone number is (703) 308-2331. The examiner can normally be reached on 8-5:30 M-F, with alternate Mondays off.

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If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Shrive Beck can be reached on (703) 308-2333. The fax phone numbers for the organization where this application or proceeding is assigned are (703) 306-3186 for regular communications and (703) 306-3186 for After Final communications.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703) 308-0661.

Michael Cleveland Patent Examiner

January 13, 2004

SHRIVE P. BECK
SUPERVISORY PATENT EXAMINER

TECHNOLOGY CENTER 1700